

**Notice of References Cited**

Application/Control No.

10/538,204

Applicant(s)/Patent Under  
Reexamination  
LEE ET AL.

Examiner

BRIAN Q. LE

Art Unit

2624

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0064685	04-2003	Kim, Young-Se	455/90
*	B	US-2003/0222846	12-2003	Nguyen, Huy	345/156
	C	US-			
	D	US-			
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	F	US-			
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	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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